**PA-938** 



[Total No. of Pages : 2

[Max. Marks : 70]

## [5927]-379

## **B.E.** (Electronics & Telecommunication Engineering) **VLSI DESIGN & TECHNOLOGY** (2019 Pattern) (Semester - VII) (404182)

Time :  $2^{1/2}$  Hours]

Instructions to the candidates

- Solve Q.1 or Q.2, Q.3 or Q.4, Q.5 or Q.6, Q.7 or Q.8. **1**)
- 2) Neat diagrams must be drawn wherever necessary.
- 3) Figures to the right indicate full marks.
- Use of electronic pocket calculator is allowed. *4*)
- Assume sitable data, if necessary. 5)
- Q1) a) Draw and explain the architecture of CPLD Explain Macrocell in detail.[10]
  - What are the technologies supported by FPGA? Explain any two of it b) detail. [8]

List and Explain in brief various Simulation and Synthesis Tool. *Q2*) a) [6]

- Draw and Explain the following for FPGA : b)
  - Logic Cell i)
  - Programmable Switch Matrix ii)
  - I/O Block iii)
- Design CMOS logic for F = AB + C(D+E). Q3) a)
  - Draw 2:1 Mux using CMOS as well as TG. Common on the savings of b) transistors using TG and CMOS method. [12]

### OR

- Define Scaling and Explain any one type of scaling and its effect on at **Q4**) a) least 4 parameters. [9]
  - Explain the following terms : b)
    - Velocity Saturation i)
    - ii) Hot Electron Effect

*P.T.O.* 

[8]

[12]

[5]

- **Q5**) a) Which Lambda rules are used for CMQS Layout? Give its significance.[6]
  - b) Explain the steps involved in fabrication of CMOS transistor with suitable diagram. [12]

# Q6) Draw the block diagram of half adder and its truth table. Draw it CMOS transistor level circuit Draw Euler's Path for both networks. Draw the stick diagram for sum and Carry (outputs) of HALF ADDER. [18]

OR

Q7) a) Explain different types of faults existing in VLSI chips. [8]
b) Explain Controllability. Observability and Predictability in testability. [9]
OR
Q8) a) Explain Path sensitization method. [8]
b) Explain JTAG boundary Scan, Explain all the pins involved. [9]